

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (DTMOS )

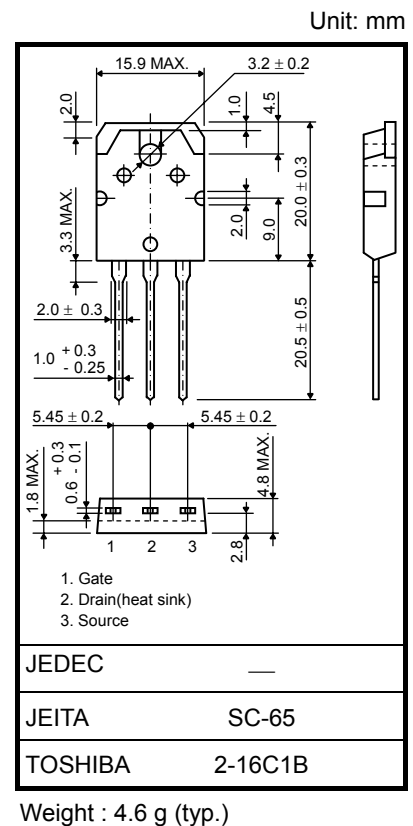
## TK12J60U

### Switching Regulator Applications

- Low drain-source ON resistance:  $R_{DS(ON)} = 0.36$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 7.0$  S (typ.)
- Low leakage current:  $I_{DSS} = 100$   $\mu$ A ( $V_{DS} = 600$  V)
- Enhancement-mode:  $V_{th} = 3.0\sim 5.0$  V ( $V_{DS} = 10$  V,  $I_D = 1$  mA)

### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	600	V
Gate-source voltage		$V_{GSS}$	$\pm 30$	V
Drain current	DC (Note 1)	$I_D$	12	A
	Pulse (t = 1 ms) (Note 1)	$I_{DP}$	24	
Drain power dissipation (Tc = 25°C)		$P_D$	144	W
Single pulse avalanche energy (Note 2)		$E_{AS}$	69	mJ
Avalanche current (Note 3)		$I_{AR}$	12	A
Repetitive avalanche energy		$E_{AR}$	14	mJ
Channel temperature		$T_{ch}$	150	°C
Storage temperature range		$T_{stg}$	-55 to 150	°C



Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

### Thermal Characteristics

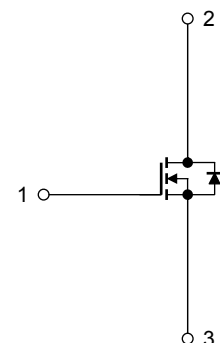
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	$R_{th(ch-c)}$	0.868	°C/W
Thermal resistance, channel to ambient	$R_{th(ch-a)}$	50	°C/W

Note 1: Please use devices on conditions that the channel temperature is below 150°C.

Note 2:  $V_{DD} = 90$  V,  $T_{ch} = 25$ °C (initial),  $L = 0.84$  mH,  $R_G = 25$   $\Omega$ ,  $I_{AR} = 12$  A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.



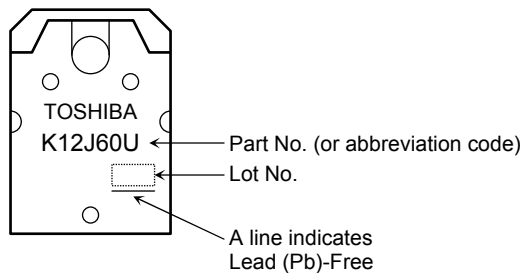
## Electrical Characteristics (Ta = 25°C)

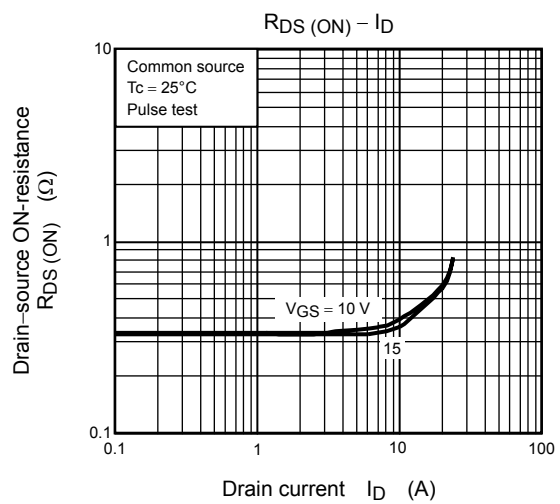
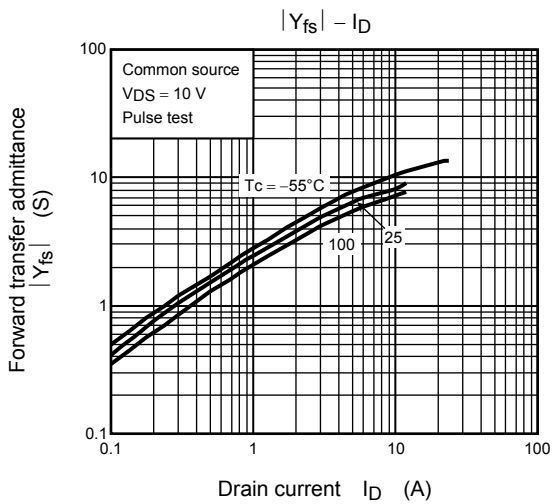
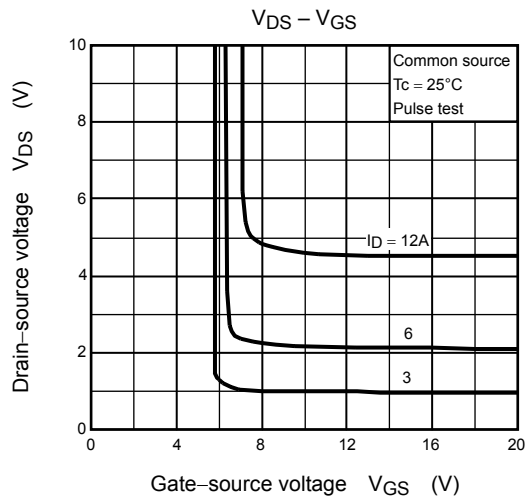
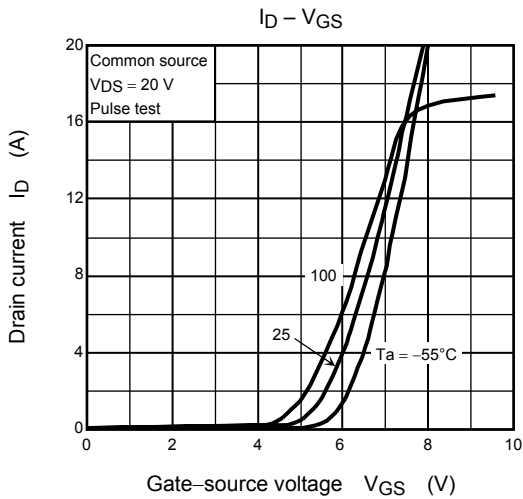
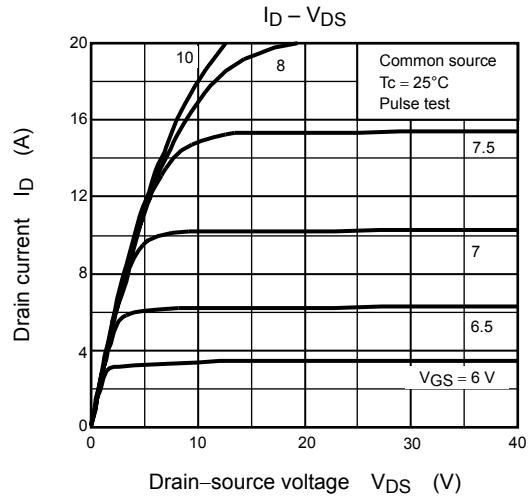
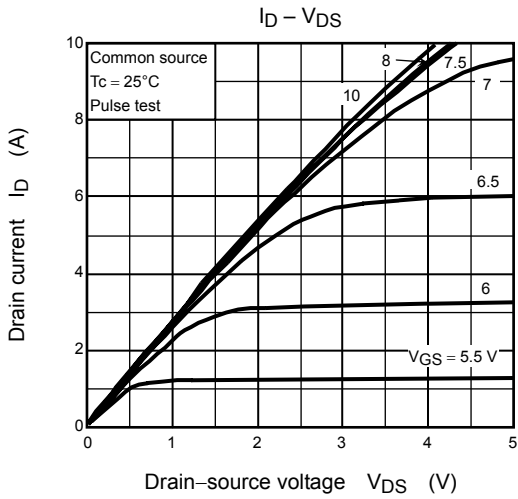
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		$I_{GSS}$	$V_{GS} = \pm 30\text{ V}, V_{DS} = 0\text{ V}$	—	—	$\pm 1$	$\mu\text{A}$
Drain cut-off current		$I_{DSS}$	$V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$	—	—	100	$\mu\text{A}$
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$	600	—	—	V
Gate threshold voltage		$V_{th}$	$V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$	3.0	—	5.0	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 6\text{ A}$	—	0.36	0.4	$\Omega$
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10\text{ V}, I_D = 6\text{ A}$	2.0	7.0	—	S
Input capacitance		$C_{iss}$	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	720	—	pF
Reverse transfer capacitance		$C_{rss}$		—	55	—	
Output capacitance		$C_{oss}$		—	1700	—	
Switching time	Rise time	$t_r$		—	30	—	ns
	Turn-on time	$t_{on}$		—	60	—	
	Fall time	$t_f$		—	8	—	
	Turn-off time	$t_{off}$		Duty $\leq 1\%$ , $t_w = 10\ \mu\text{s}$	—	75	
Total gate charge		$Q_g$	$V_{DD} \approx 400\text{ V}, V_{GS} = 10\text{ V}, I_D = 12\text{ A}$	—	14	—	nC
Gate-source charge		$Q_{gs}$		—	8.5	—	
Gate-drain charge		$Q_{gd}$		—	5.5	—	

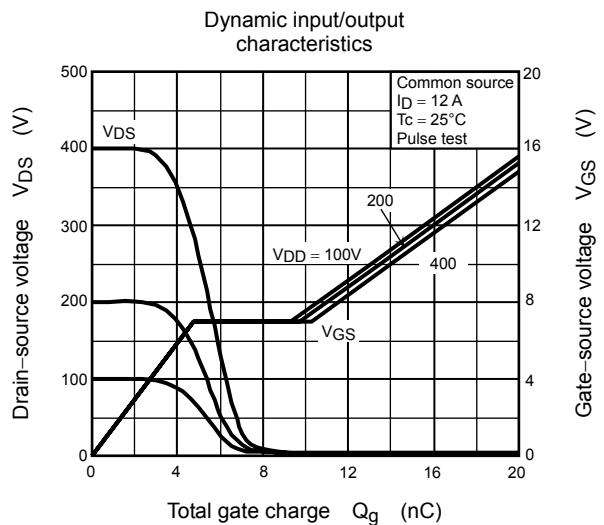
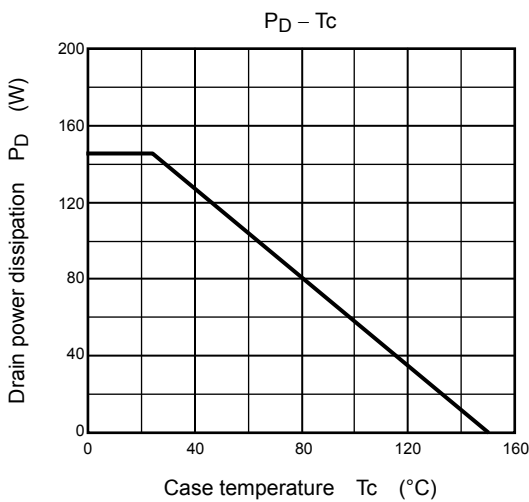
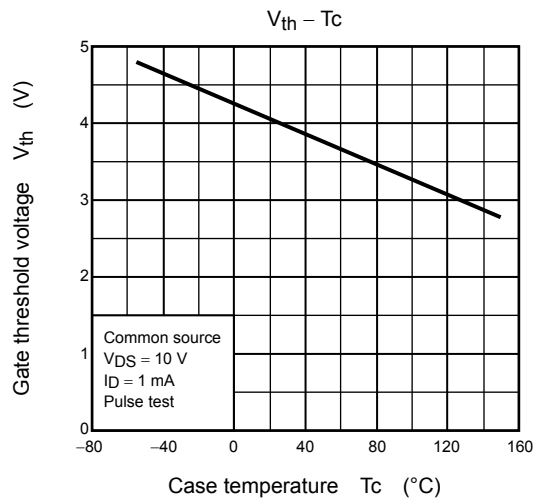
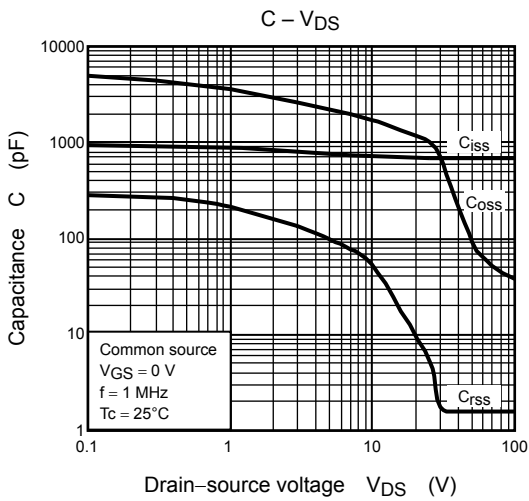
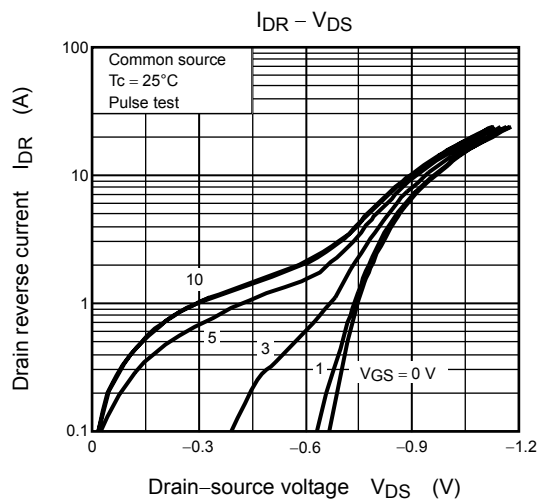
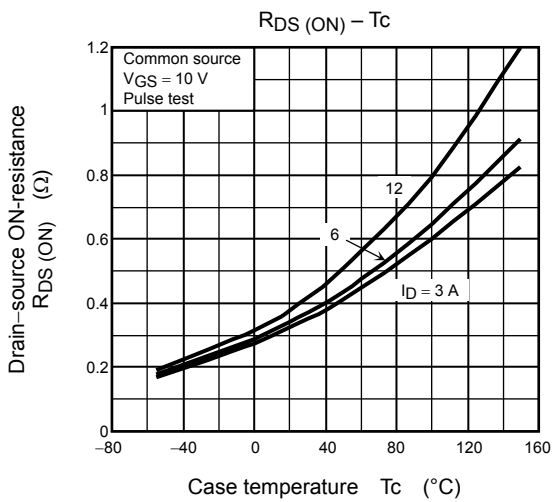
## Source-Drain Ratings and Characteristics (Ta = 25°C)

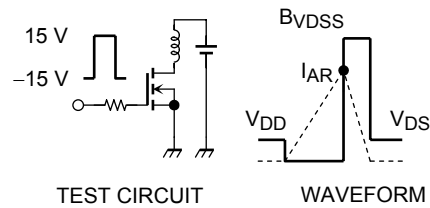
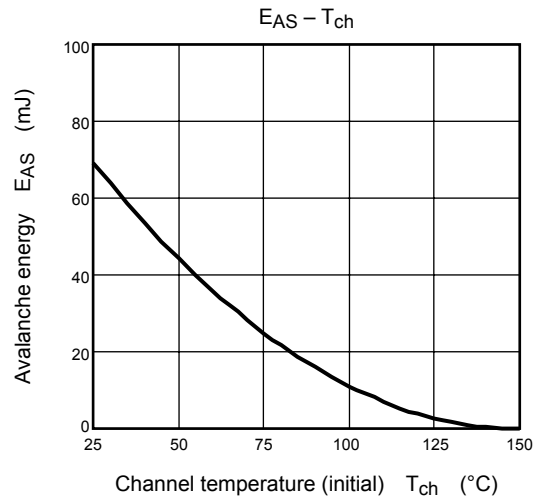
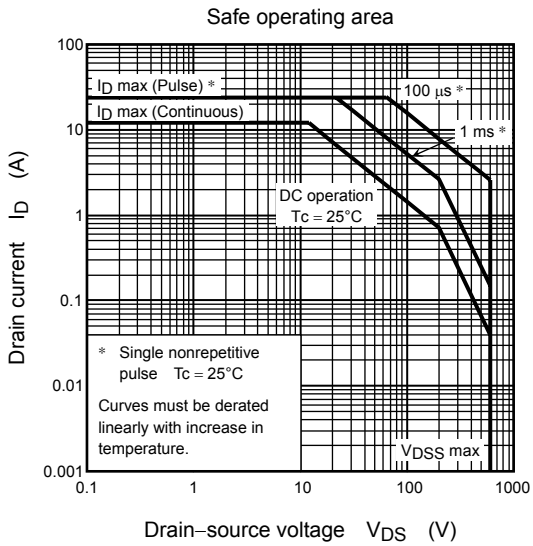
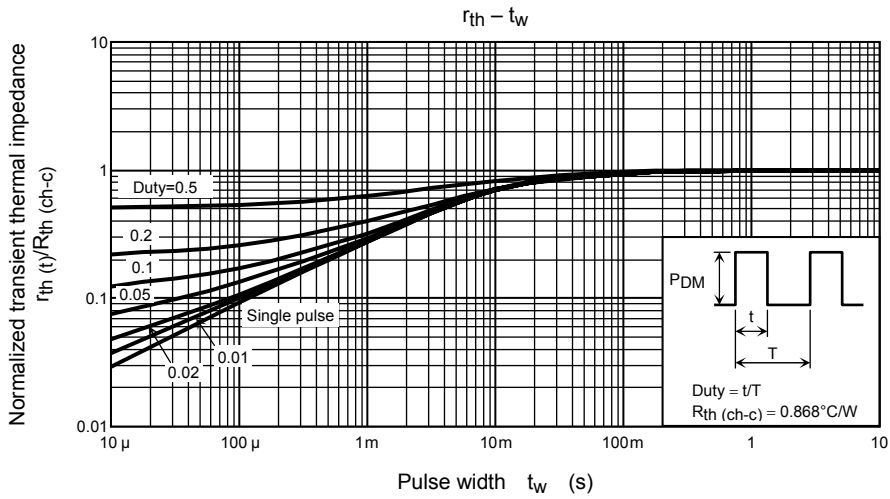
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current (Note 1)	$I_{DR}$	—	—	—	12	A
Pulse drain reverse current (Note 1)	$I_{DRP}$	—	—	—	24	A
Forward voltage (diode)	$V_{DSF}$	$I_{DR} = 12\text{ A}, V_{GS} = 0\text{ V}$	—	—	-1.7	V
Reverse recovery time	$t_{rr}$	$I_{DR} = 12\text{ A}, V_{GS} = 0\text{ V},$	—	380	—	ns
Reverse recovery charge	$Q_{rr}$	$dI_{DR}/dt = 100\text{ A}/\mu\text{s}$	—	5.3	—	$\mu\text{C}$

## Marking









$R_G = 25 \Omega$   
 $V_{DD} = 90 \text{ V}, L = 0.84 \text{ mH}$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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